

<b>Notice of References Cited</b>	Application/Control No. 10/064,477		Applicant(s)/Patent Under Reexamination FANO, ANDREW E.	
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*	B	US-6,023,705	02-2000	Bellinger et al.	707/200
*	C	US-6,144,375	11-2000	Jain et al.	715/500.1
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*	E	US-5,822,537	10-1998	Katseff et al.	709/231
*	F	US-2001/0031066	10-2001	Meyer et al.	382/100
*	G	US- <del>2,002,000</del> 72	05-1935	COLBURN JR ERNEST A 2,002,000	366/164.6
*	H	US-6,151,632	11-2000	Chaddha et al.	709/231
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